

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/541,748	HARADA ET AL.	
Examiner	Art Unit	
Sai-Ming Chan	2616	

SEARCHED					
Class	Subclass	Date	Examiner		
455	452.2	12/15/2007	sc		
			,		
-					

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
		<u> </u>			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST Image and keyword search in USPAT, US-PGPUB, DERWENT, EPO, JPO, and IBM_TDB (see attached search strategy)	12/15/2007	sc		
Inventor name and Assignee search in PALM EXPO and EAST	12/15/2007	sc		
`				